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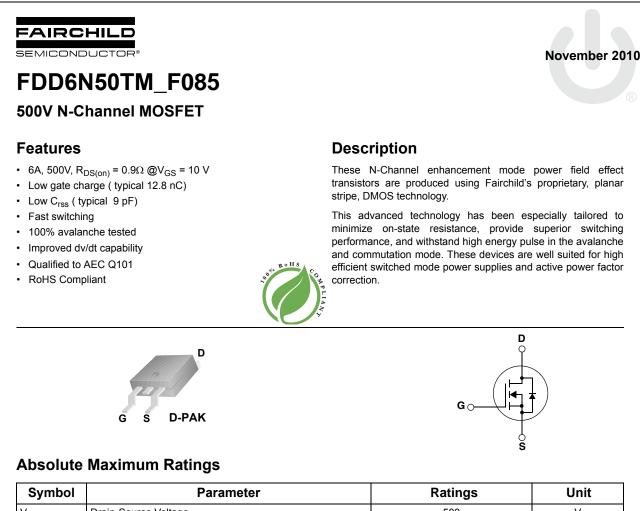
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Fairchild Semiconductor FDD6N50TM_F085

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Symbol	Parameter			Ratings	Unit	
V _{DSS}	Drain-Source Voltage			500	V	
ID	Drain Current	- Continuous (T _C = 25°C - Continuous (T _C = 100°		6 3.8	A A	
I _{DM}	Drain Current	- Pulsed	(Note 1)	24	A	
V _{GSS}	Gate-Source voltage			±30	V	
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	270	mJ	
I _{AR}	Avalanche Current		(Note 1)	6	A	
E _{AR}	Repetitive Avalanche Energy		(Note 1)	8.9	mJ	
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	4.5	V/ns	
P _D	Power Dissipation	Power Dissipation (T _C = 25°C) - Derate above 25°C		89 0.71	W W/°C	
T _{J,} T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C	
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		ose,	300	°C	

Thermal Characteristics

Symbol	Parameter	Min.	Max.	Unit	
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case		1.4	°C/W	
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient		83	°C/W	

FDD6N50TM_F085 500V N-Channel MOSFET



Device Marking FDD6N50		Device	Package	Reel Size	Tape Width 16mm		Quantity 2500	
		FDD6N50TM_F085	D-PAK	380mm				
Electric	al Chara	acteristics T _c = 25°C unl	ess otherwise noted					
Symbol	Parameter		Conditions		Min.	Тур.	Max	Units
Off Charac	teristics							
BV _{DSS}	Drain-Source Breakdown Voltage		$V_{GS} = 0V, I_{D} = 2$	500			V	
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient		I _D = 250μA, Ref		0.5		V/°C	
I _{DSS}	Zero Gate Voltage Drain Current		V _{DS} = 500V, V _G V _{DS} = 400V, T _C			1 10	μΑ μΑ	
I _{GSSF}	Gate-Body Leakage Current, Forward		V _{GS} = 30V, V _{DS}			100	nA	
I _{GSSR}	Gate-Body	Leakage Current, Reverse	V _{GS} = -30V, V _{DS}			-100	nA	
On Charact	eristics							
V _{GS(th)}	Gate Threshold Voltage		$V_{DS} = V_{GS}, I_D =$	3.0		5.0	V	
R _{DS(on)}	Static Drain-Source On-Resistance		V _{GS} = 10V, I _D =		0.76	0.9	Ω	
9 _{FS}	Forward Tra	ansconductance	ce $V_{DS} = 40V, I_D = 3A$ (Note 4))	2.5		S
Dynamic C	haracteristi	cs						
C _{iss}	Input Capacitance Output Capacitance		V _{DS} = 25V, V _{GS} = 0V, f = 1.0MHz			720	940	pF
C _{oss}						95	190	pF
C _{rss}	Reverse Tr	ansfer Capacitance				9	13.5	pF
Switching	Characteris	tics						
t _{d(on)}	Turn-On Delay Time		$V_{DD} = 250V, I_D = 6A$			6	20	ns
t _r	Turn-On Ri	se Time	R _G = 25Ω	$R_{G} = 25\Omega$		55	120	ns
t _{d(off)}	Turn-Off De	elay Time				25	60	ns
t _f	Turn-Off Fa	all Time		(Note 4, 5)	35	80	ns
Qg	Total Gate	Charge	$V_{DS} = 400V, I_D = 6A$ $V_{GS} = 10V$ (Note 4, 5)			12.8	16.6	nC
Q _{gs}	Gate-Source	ce Charge				3.7		nC
Q _{gd}	Gate-Drain	Charge)	5.8		nC
Drain-Sour	ce Diode Cl	naracteristics and Maximu	n Ratings					
I _S	Maximum (Continuous Drain-Source Dic	de Forward Curre			6	Α	
I _{SM}	Maximum F	Pulsed Drain-Source Diode F	orward Current			24	А	
V _{SD}	Drain-Sour	ce Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 6$	A			1.4	V
t _{rr}	Reverse Re	ecovery Time	V _{GS} = 0V, I _S = 6A dI _F /dt =100A/µs (Note 4)			275		ns
Q _{rr}	Reverse Re	ecovery Charge)	1.7		μC

NOTES:

1. Repetitive Rating: Pulse width limited by maximum junction temperature

2. I_{AS} = 6A, V_{DD} = 50V, L=13.5mH, R_G = 25 Ω , Starting T_J = 25°C

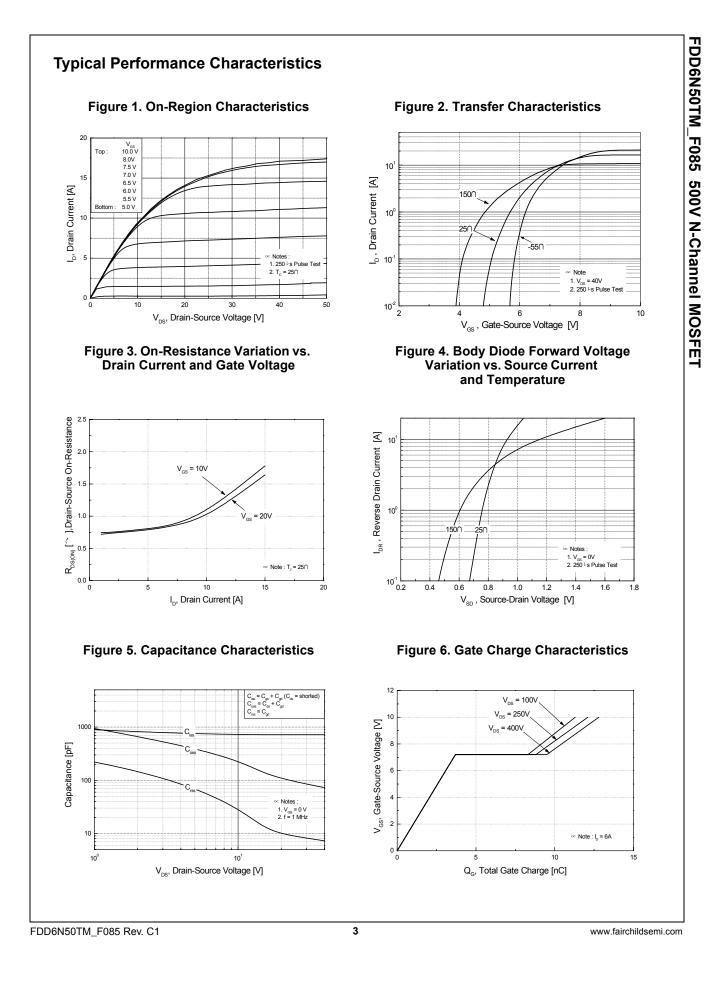
3. I_{SD} \leq 6A, di/dt \leq 200A/\mu s, V_{DD} \leq BV_{DSS}, Starting T _ = 25°C

4. Pulse Test: Pulse width $\leq 300 \mu \text{s}, \, \text{Duty Cycle} \leq 2\%$

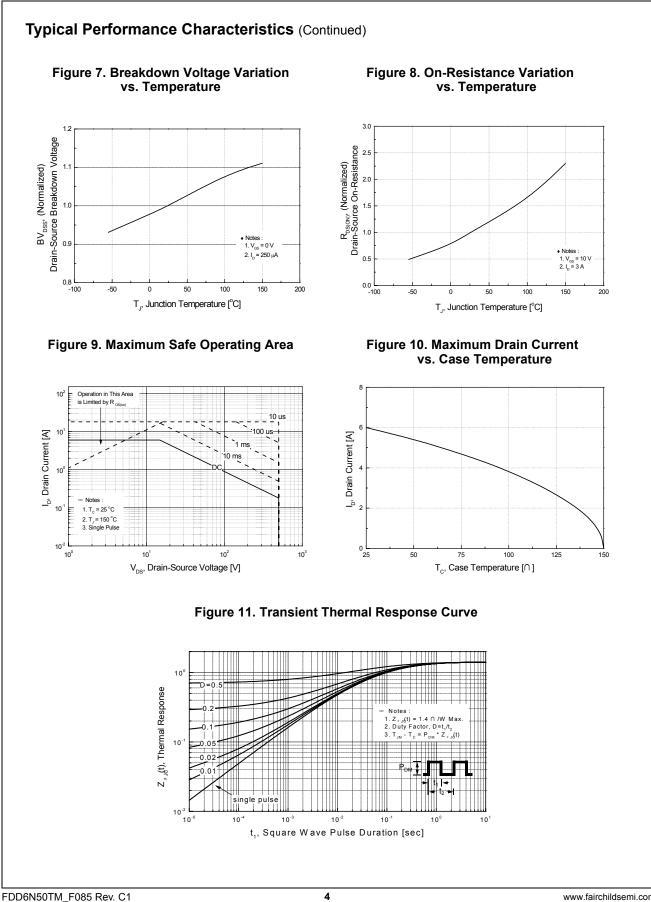
5. Essentially Independent of Operating Temperature Typical Characteristics

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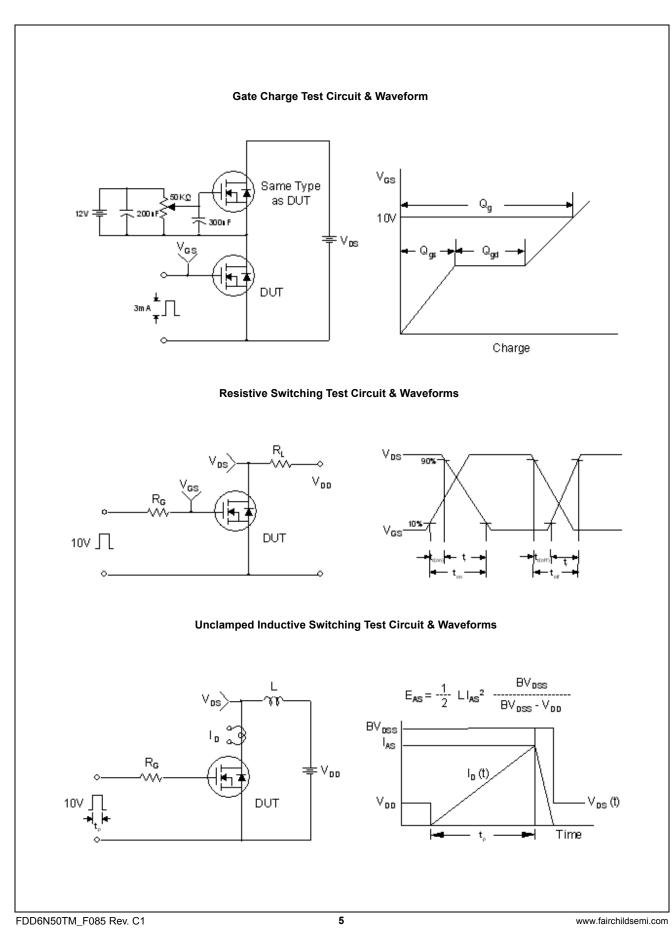




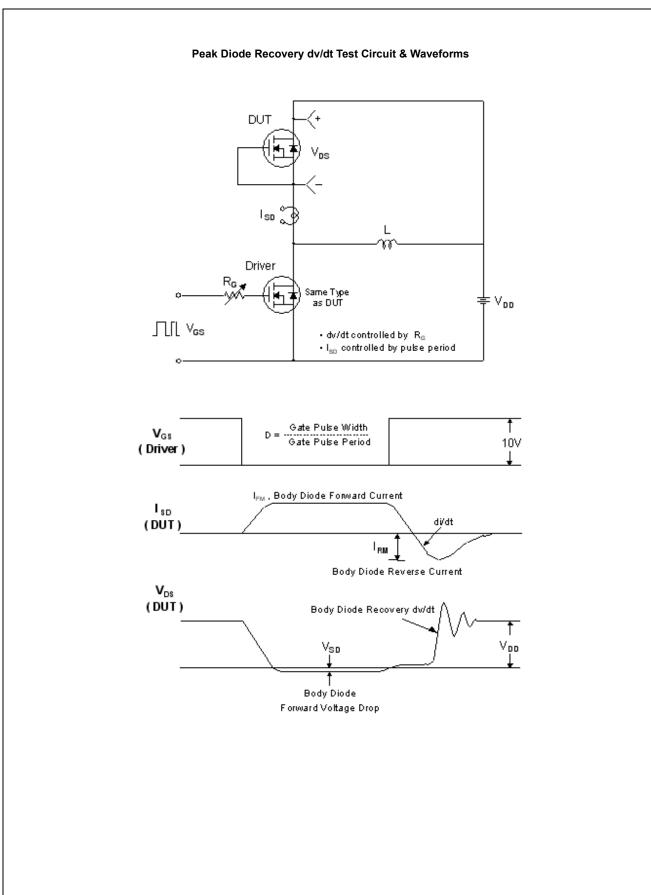


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FDD6N50TM_F085 Rev. C1



